Shot-noise characteristics of triple-barrier resonant-tunneling diodes

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We have found experimentally that the shot noise in InA IA s-InG aA s-InA IA s Triple-Barrier Resonant-Tunneling D iodes (TBRTD) is reduced over the 2eI Poissonian value whenever their di erential conductance is positive, and is enhanced over 2eI when the di erential conductance is negative. This behavior, although qualitatively sim ilar to that found in double-barrier diodes, di ers from it in important details. In TBRTD s the noise reduction is considerably larger than predicted by a sem iclassicalm odel, and the enhancem ent does not correlate with the strength of the negative di erential conductance. These results suggest an incom plete understanding of the noise properties of m ultiple-barrier heterostructures.

The measurement of shot noise, in combination with electrical conductance, is an important tool to elucidate electronic transport in mesoscopic devices. If the electronic noise is created random ly, its spectral density, $S_{\rm I}$ (!), has the value 2eI and we speak of Poissonian or full shot noise. But if the motion of the charged carriers is correlated, then there are deviations (either reduction or enhancement) from the Poissonian value.¹ A measure of these deviations is given by the so-called Fano factor, F, de ned as the ratio of the actual noise spectral density to the full shot noise value.

One of the mesoscopic devices that best illustrates non-Poissonian noise due to electron correlation is the Double-Barrier Resonant-Tunneling Diode (DBRTD). Its current-voltage characteristic (I-V) usually has a quasi-triangular shape, with an initial region of positive di erential conductance (PDC) followed by a sharp negative di erential conductance (NDC). Shot noise in a DBRTD is partially suppressed (i.e., it is sub-Poissonian) in the PDC region² and enhanced above 2eI, (i.e., super-Poissonian) in the NDC region.^{3,4} The reduction of noise has been explained by correlation e ects due to Pauli's exclusion principle,² while the enhancem ent has been accounted for by a positive-feedback correlation.^{3,5,6} The transition from the sub-Poissonian to the super-Poissonian regime at, or near, the current peak has been studied by considering the potential uctuations induced by charge uctuations in the quantum well. Experim entally, it has been shown that the larger the absolute value of the negative di erential conductance, the larger the noise enhancement, a and it has been unequivocally established that charge accumulation is essential to the enhancem ent of shot noise in a DBRTD.

Shot-noise measurements in DBRTDs have been limited to devices with relatively thick barriers, in which tunneling is sequential. A lthough several calculations have shown that in multiple-barrier structures the shotnoise reduction should be independent of whether the electronic transport is sequential or coherent,⁹ other calculations have predicted a smaller shot noise when the process is coherent. For instance, while a sequential-

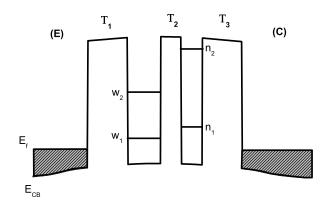


FIG.1: Conduction-band pro le of sam ple A (see text) under at-band condition (zero bias). The solid lines in the quantum wells show the quasi-bound energy levels. The em itter (adjacent to the substrate) and the collector are n-type doped regions denoted by (E) and (C), respectively. T_i represents the transm ission probability for the i-th barrier.

tunneling model predicts a minimum sub-Poissonian noise of 0.41 in a triple-barrier structure,⁹ there are calculations that, assuming coherent transport, anticipate a minimum sub-Poissonian Fano factor that ranges from 0.41 to 0.22, depending on the details of the heterostructure.^{10,11,12} A Triple Barrier Resonant Tunneling Diode (TBRTD) is in principlem ore suitable than a DBRTD to study the e ect of coherence on noise since in the TBRTD the coupling between its two wells can be varied by adjusting the thickness of the middle barrier, while maintaining the low current necessary for noise m easurem ents with thick end barriers.

Before addressing the question of coherence it is in portant to compare system atically the sequential-tunneling noise of DBRTDs and TBRTDs, especially in light of the

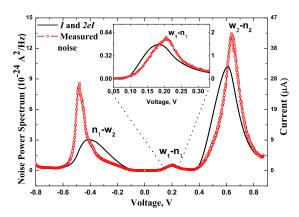


FIG.2: Current (solid line) and shot noise (circles) characteristics of sample A (see text), measured with the diode at T = 42 K. The scales for current and noise, shown on the right and left vertical axes, respectively, di er by a factor of 2e so that the current I, read using the left scale, can be regarded as 2eI. The inset shows a blow-up of 2eI and the m easured shot noise around the w_1 n_1 resonance.

very limited experimental information on the latter. In the only study we know, it was found that at the onset of the tunneling current shot noise was 2eI and then became progressively smaller, with a minimum value of 0.7 as the current approached its peak value.¹³ Such a decrease is surprising, and is at odds with what is predicted theoretically and with the behavior found in DBRTDs.¹

As a rst step toward the goal of measuring the shot noise of strongly coupled quantum wells, we have studied the noise of thick TBRTDs in both the PDC and NDC regions and com pared it with that of a \control" DBRTD. We have found that in the PDC region the noise reduction was considerably larger in the TBRTDs than previously observed and theoretically predicted by a sem iclassicalm odel. In the NDC region of these devices, we found noise enhancement, as in a DBRTD, but for one of the two bias polarities that enhancement was anom alously large relative to what is found in a DBRTD of com parable negative di erential conductance.

Our TBRTDs and DBRTD were prepared using lattice-m atched InG aAs-InA lAs epitaxial layers grown by metal-organic chem ical vapor deposition on InP substrates. The con guration was the same in all the diodes: two heavily doped n-type electrodes with an undoped active region in between. The electrode next to the substrate ('emitter') wasmade of 500 A ofn⁺ In_{0.53}G a_{0.47}As (1 10^{19} cm 3) and 2000 A ofn⁺ In_{0.53}G a_{0.47}As (1 10^{18} cm 3) followed by an undoped In_{0.53}G a_{0.47}As spacer layer of 50 A. The top electrode ('collector') had the same structure as the bottom electrode. The active region of sample A consisted of the following: 100 A of In_{0.52}A l_{0.48}As (barrier), 53 A of In_{0.53}G a_{0.47}As (well), and 100 A of In_{0.52}G a_{0.48}As (barrier). Sample B

was identical to sample A except for the thickness of the m iddle barrier, which was 100 A. The active region of the DBRT (sample C) consisted of 100 A of $In_{0:52}A \downarrow_{0:48}A s$ (barrier), 53 A of $In_{0:53}Ga_{0:47}A s$ (well) and 100 A of $In_{0:52}A \downarrow_{0:48}A s$ (barrier). The diodes were de ned by photolithography and wet etching to a size of 20x20 m².

Transport and shot noise m easurements were done at 42K with the device immersed in liquid helium. The current-voltage characteristic of each sample was determined by biasing it through a low noise, battery-powered voltage follower (that reduced the source impedance from the voltage source) and recording the voltage drop across a calibrated resistor in series with the sample. Conductance was measured using an AC modulation voltage with 0.1mV rm samplitude and detecting the corresponding drop across that resistor with a lock-in amplier. Positive bias is de ned here as the voltage polarity for which electrons tunnel from the emitter into the wider quantum well and then into the narrower well.

To measure noise, the samples were connected in series to a very low noise, battery-powered current amplier. The output noise of the ampli er, which consists of the noise from the sample, ampli er noise, therm alnoise and background noise, was measured by a spectrum analyzer at 5kHz at 1mV intervals. The sample's noise was determ ined as follows: rst, the noise data recorded by the spectrum analyzer were divided by the ampli cation gain; then, the ampli er and therm al noises were subtracted; nally, the background noise, determ ined using several calibrated m etal lm resistors, was subtracted.

Since the results from the two TBRTDs were similar, in the following we will focus on sample A, whose conduction band pro le at zero bias is shown in Fig.1. The bound-state energies in the wider (narrower) well, denoted by w_1 (n_1) and w_2 (n_2), are 41 (93) m eV and 235 (425) m eV above the Ferm i level, respectively.¹⁴ Under positive bias, the energy separation between w_1 and n_1 dim inishes and at a certain voltage both levels become aligned (resonant condition) while being below the Ferm i level. Conservation of energy and parallel (to the layers' planes) m om entum favor electron tunneling at that voltage and, as a result, the current has a strong spike. Ideally, at voltages below or above resonance the current should be negligible. The situation repeats itself when w_2 and n_2 become aligned at even higher voltage and, under reverse bias, when w_2 and n_1 are in resonance.

As shown in Fig. 2, the I-V characteristic of sample A at T = 4.2K exhibits the predicted behavior, broadly speaking. The two current peaks in forward bias correspond to the w $_1$ n_1 and w_2 n_2 resonances, while the peak in reverse bias is for the n_1 w_2 resonance. (At 77K the I-V characteristic did not change much, but at 300K, although the w_1 n_1 and n_1 w₂ were still apparent, there was a substantial therm ally activated current background.) There is, though, a clear di erence between the predicted and observed behavior. Experimentally the current rise is gradual (see, e.g., the voltage region between 0.075 and 0.175 V or between -0.1 V

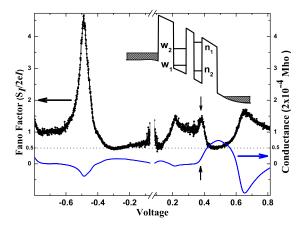


FIG.3: Experim ental Fano factor (circles) and conductance (solid line) of sample A as a function of voltage. A los shown is a diagram of the conduction band prole at a voltage between the w_1 n_1 and w_2 n_2 resonances. The vertical arrows at 0.38 V point to an anom alous peak in the noise characteristic and a corresponding (weak) feature in the conductance. The Fano factor in the region between -0.1V and 0.1V is not shown because its uncertainty was extrem ely large due to the very sm all current, in comparison with that at other voltages.

and -0.4 V, in Fig. 2), which contrasts with the deltafunction-like characteristic that energy and momentum conservation dem and. This di erence is attributed to the non-conservation of parallelm om entum, and will be discussed in detail elsewhere.¹⁵

Figure 2 also shows the measured shot noise characteristic for sample A and compares it with the Poissonian value 2eI. As it is apparent in the gure, the shot noise is reduced below 2eI whenever the current rises and is enhanced when the current drops. This behavior is qualitatively similar to that found in sample C and in previous reports about noise in DBRTDs.^{2,3,4,8} The deviation of the shot noise from the Poissonian value is best illustrated by plotting the Fano factor F , shown in F ig 3 along with the conductance. For the w_1 n peak, it is F = 0:55 0:06 at 0.17V (the lowest voltage at which the current is su ciently high to make a meaningful determ ination of noise in our set-up) and then F increases gradually, passing the value of 1 and reaching a localmaximum of 1.4 when the di erential conductance is negative and has a minimum value (at V = 0.23V). Further on, still in the NDC region, F goes back to 1 but then increases and has a new maximum at 0.38V, before decreasing and m erging with the features of the w_2 nþ peak.

For this second peak, F increases from an initial value of 0:50 0:02, reaches a maximum value of 1.5 when the conductance is minimum (V = 0.65V), and then grad-ually reverts to 1. The same behavior is observed for the n_1 w₂ peak in reverse bias, with a minimum F of 0:48 0:02 and a maximum of 4.6. There is a no-

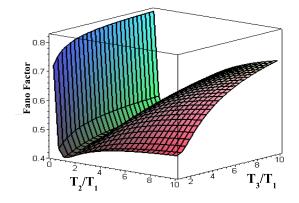


FIG.4: Simulated three-dimensional plot of the calculated Fano factor in a triple barrier structure in which the tunneling probabilities through the individual barriers are given by $T_1;T_2$, and T_3 . The calculation was done using a sem iclassicalm odel that assumes sequential tunneling throughout the structure. The Fano factor has a minimum value of 0.41 when the tunneling probability is the same for all three barriers. W hen the probabilities are very di erent from each other the Fano factor approaches unity.

ticeable di erence, how ever, between both polarities: the enhancem ent of the Fano factor for the current peak under reverse bias is at least three times larger than for any of the two peaks under forward bias. For comparison, in sample C (the control D BRTD) the minimum and maximum Fano factors were found to be $0.51 \quad 0.02$ and $12 \quad 0.1$, respectively.

At this point, it is worth sum marizing the experim ental facts. First, the noise behavior of both TBRTDs is qualitatively similar to that of the controlDBRTD and other DBRTDs studied before, 2,3,4,8 but it contrasts with the unusualnoise dependence in a TBRTD reported earlier.¹³ Second, the minimum value of F is around 0.5 for the two TBRTDs we have studied, even though the thickness of the central barrier in sample A was quite di erent from that of the end barriers. Third, there is an unusual (local) maximum Fano factor, without a corresponding well-de ned feature in the conductance. Fourth, the enhanced Fano factor for the n_1 w_2 peak is three times larger than for any of the other two peaks, even though the corresponding m in im um in the conductance is much less pronounced for n_1 w_2 than for w_2 n₂.

To compare our experimental minimum F values with theoretical predictions, we calculated the shot noise using a sequential-tunneling model developed to treat shot noise in a multiple-barrier system.⁹ G iven the barrier thickness of our samples, it is appropriate to see the tunneling process as sequential, a regime in which quantum and sem i-classical models give the same answer.¹⁰

The results of our calculations are summarized in Fig.4, where in a simulated three-dimensional plot we represent the Fano factor as a function of the ratios $T_2=T_1$

and $T_3=T_1$ (T_1 is the transm ission probability through the i-th barrier, considered individually). If the tunneling probability through the emitter and collector barriers is the same, that is, $T_3 = T_1$, and the central barrier is not thicker than either of the two end barriers ($T_2 = T_1$) then, according to Fig.4, the minimum Fano factor should range between 0.41 (when $T_2 = T_1$) and 0.5 (when $T_2 = T_1$, that is, in the DBRT limit). Thus the calculation predicts that at zero bias the Fano factor for sam ple A should be close to 0.5 while that of sam ple B should approach 0.41.

W hen a bias is applied to the TBRTD the potential probabilities can change considerably. Using a Schrödinger-Poisson solver and the transfer matrix method^{14,16} to calculate T (E) for each tunnelbarrier, we have obtained T₃ and T₁ as a function of voltage. For sam ple A, at V = 0.11V (the onset of the w₁ n₁ peak) the probability ratio T₃=T₁ thus determ ined was 7.9 and the corresponding Fano factor was F = 0.80, to be com pared with an experim entalvalue of 0.55 0.06. For sam ple B (at V = 0.17V) the calculated and experimental values for F were 0.51 and 0.44 0.06, respectively.

For resonances at higher voltages, the discrepancy between calculation and experiment is larger. Thus, in sam – ple A, at V = 0.46V (the current onset of the w_2 n_2 peak), $T_3=T_1 > 400$ and the calculated factor was 1.0. For V = -0.29V, (the onset of n_1 w_2 peak) $T_3=T_1$ 50 and F = 0.98. In sharp contrast, experimentally, for both voltages it is F 0.5. This large di erence between theory and experiment, also observed in sam ple B, is well outside our experimental uncertainty and remains unexplained. (As a reference, for the control D BRTD that di erence was minimal: 0.55 vs 0:51 0:06.)

The enhancement of the shot noise at 0.38 V, marked by vertical arrows in Fig.3 and also observed in sam – ple B, may be due to phonon-assisted tunneling via the emission of a LO-phonon in the InG aAs layer. (There is also a hint of a related feature in the conductance). The voltage at which the enhancement occurred is consistent with that interpretation, but it is not clear why then a similar enhancement is not observed for the other two resonances.

The large enhancement of the Fano factor we have observed in the NDC region of the n_1 w₂ peak deserves special attention, since it runs counter to our understanding of the origin of noise enhancement in a DBRTD^{3,4} (and by extension in a TBRTD), which is as follows.

Since in the NDC region the quantum -well level is already below the conduction-band edge of the em itter, the density of states (DOS) for tunneling into the well is quite sm all. But when an electron does tunnel it charges the well and m odi es the potential pro le, pushing the center of the DOS higher in energy and thus enhancing the probability for a second electron to tunnel. This positive correlation increases the shot noise; the sharper the density of states the m ore pronounced is the NDC { and the larger the shot-noise enhanced should be.

This intuitive prediction has been con med experimentally in InAs-A ISb-G aSb DBRTDs, in which, using a magnetic eld to control the strength of the NDC, it was found that F increased monotonically with increasingly stronger NDC.⁴ In both of our TBRTDs the correlation holds when we compare the strengths of the NDC for the w₁ n_1 and the w₂ n_2 resonances, but it breaks down when the n_1 w_2 resonance is included (see Fig. 3).

Regarding noise, no polarity asymmetry was found in the controlDBRTD. W hat makes then the forwardand reverse-bias current peaks di erent in TBRTDs that could a ect the enhancement of noise? The only apparent di erence between the $n_1 \quad w_2$ peak and either the $w_1 \quad n_1$ or the $w_2 \quad n_2$ peak lies in the relative symmetry of the quantum states involved in the tunneling process. At zero bias, the wavefunctions of the w_1 and n_1 states are symmetric, relative to the center of their corresponding wells, while the w_2 and n_2 are antisymmetric. It is unclear, though, how this di erent symmetry could a ect shot noise, especially at high bias, when the symmetry of the wavefunction is greatly reduced.

Some light m ight be shed into this unresolved puzzle by m easuring the shot noise of a TBRTD identical to sam ple A (or sam ple B) but with the order of the two quantum wells reversed relative to the sam ple's substrate. If the anom alous noise enhancement that we have observed is indeed only a consequence of the electron wavefunctions' asymmetry then the new I-V and noise characteristics should be the same as those in Figs. 2 and 3, but with opposite polarity. Were this the case, it would then be most interesting to explore the elect of the central barrier on that enhancement and, naturally, to approach the regime of strongly coupled wells, where coherence m ight also a ect shot noise.

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